U74CBTLV3257

**Preliminary** 

**CMOS IC** 

# LOW-VOLTAGE DUAL 4-BIT 1-OF-2 FET MULTIPLEXER/DEMULTIPLEXER

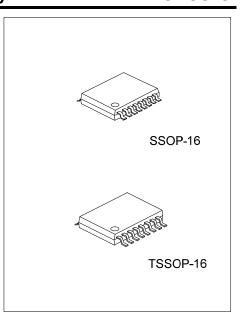
#### **■** DESCRIPTION

The **U74CBTLV3257** device is a 4-bit 1-of-2 high-speed FET multiplexer/demultiplexer. The low on state resistance of the switch allows connections to be made with minimal propagation delay.

The select (S) input controls the data flow. The FET multiplexers/demultiplexers are disabled when the output-enable ( $\overline{\text{OE}}$ ) input is high.

This device is fully specified for partial-power-down applications using loff. The loff feature ensures that damaging current will not backflow through the device when it is powered down. The device has isolation during power off.

To ensure the high-impedance state during power up or power down,  $\overline{\text{OE}}$  should be tied to  $V_{\text{CC}}$  through a pull-up resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

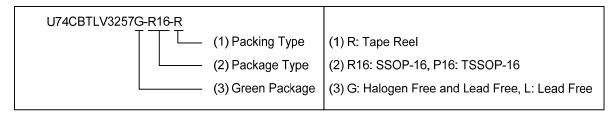


#### ■ FEATURES

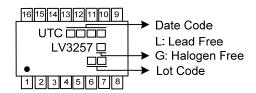
- \* 5Ω Switch Connection Between Two Ports
- \* Rail-to-Rail Switching on Data I/O Ports
- \* I<sub>OFF</sub> Supports Partial-Power-Down Mode Operation

### ■ ORDERING INFORMATION

Ordering	Number	Dealters	Dealine
Lead Free	Halogen Free	Package	Packing
U74CBTLV3257L-R16-R	U74CBTLV3257G-R16-R	SSOP-16	Tape Reel
U74CBTLV3257L-P16-R	U74CBTLV3257G-P16-R	TSSOP-16	Tape Reel

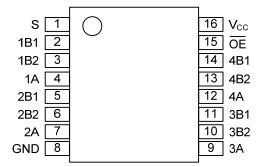


#### ■ MARKING



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## **■ PIN CONFIGURATION**



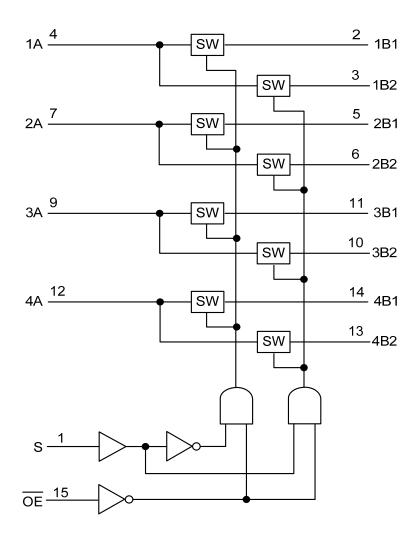
## **■ PIN DESCRIPTION**

PIN NO.	PIN NAME	I/O	DESCRIPTION
1	S	I	Select
2	1B1	I/O	I/O Channel 1 I/O 1
3	1B2	I/O	I/O Channel 1 I/O 2
4	1A	I/O	Channel 1 O/I common
5	2B1	I/O	I/O Channel 2 I/O 1
6	2B2	I/O	I/O Channel 2 I/O 2
7	2A	I/O	Channel 2 O/I common
8	GND	-	Ground
9	3A	I/O	Channel 3 O/I common
10	3B2	I/O	I/O Channel 3 I/O 1
11	3B1	I/O	I/O Channel 3 I/O 2
12	4A	I/O	Channel 4 O/I common
13	4B2	I/O	I/O Channel 4 I/O 1
14	4B1	I/O	I/O Channel 4 I/O 2
15	ŌĒ	I	Output Enable, Active-Low
16	Vcc	-	Power

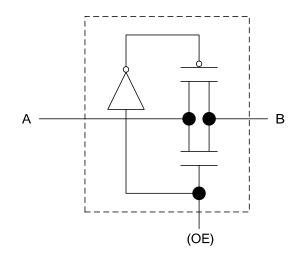
# ■ **FUNCTION TABLE** (Each Multiplexer / Demultiplexer)

INP	UTS	FUNCTION			
ŌĒ	S	FUNCTION			
L	L	A port = B1 port			
L	Н	A port = B2 port			
Н	Х	Disconnect			

# ■ LOGIC DIAGRAM (positive logic)



# ■ SIMPLIFIED SCHEMATIC (each FET switch)



#### ABSOLUTE MAXIMUM RATING

PARAMETER	SYMBOL	CONDITIONS	RATINGS	UNIT
Supply Voltage	$V_{CC}$		-0.5 ~ 4.6	V
Input Voltage (Note 2)	$V_{IN}$		-0.5 ~ 4.6	V
Continuous Channel Through V <sub>CC</sub> or GND			128	mA
Input Clamp Current	I <sub>IK</sub>	V <sub>IN</sub> <0	-50	mA
Junction Temperature	$T_J$		+150	°C
Storage Temperature Range	$T_{STG}$		-65 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### **■ THERMAL DATA**

PARAMETER		SYMBOL	RATINGS	UNIT
lum ation to Ameleiant	SSOP-16	0	120	°C/W
Junction to Ambient	TSSOP-16	$\Theta_{JA}$	110	°C/W

#### ■ RECOMMENDED OPERATING COMDITIONS

(Over operating free-air temperature range, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	Vcc		2.3		3.6	V
Himb control in mutualtana		V <sub>CC</sub> =2.3V~2.7V	1.7			.,
High-control input voltage	V <sub>IH</sub>	V <sub>CC</sub> =2.7V~3.6V	2			V
Lave agentual immediately	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	V <sub>CC</sub> =2.3V~2.7V			0.7	.,
Low-control input voltage V <sub>IL</sub>	$V_{IL}$	V <sub>CC</sub> =2.7V~3.6V			0.8	V
Operating Temperature	T <sub>A</sub>		-40		+125	°C

Note: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation.

# ■ ELECTRICAL CHARACTERISTICS (Unless otherwise specified)

PARAMETER SYMBOL		TEST CONDITIONS		T <sub>A</sub> =25°C		T <sub>A</sub> =-40°C~+125°C			LINIT			
PARAMET	EK	SYMBOL	IESI	CONDIT	IONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
Digital Input Diode	e Voltage	$V_{IK}$	$V_{CC} = 3V, I_1$	=-18mA				-1.2			-1.2	V
Input Leakage Cu	rrent	I <sub>I</sub>	V <sub>CC</sub> =3.6V,	V <sub>I</sub> =V <sub>CC</sub> oi	GND			±1			±20	μΑ
Power off Leakag	e Current	I <sub>OFF</sub>	$V_{CC}=0$ , $V_{I}$	or V <sub>O</sub> =0 to	3.6V			±15			±50	μΑ
Quiescent Supply	Current	Icc	V <sub>CC</sub> =3.6V, I <sub>O</sub> =0	V <sub>CC</sub> =3.6V, V <sub>I</sub> = V <sub>CC</sub> or GND,				10			50	μΑ
Additional Quiescent Supply Current (Note 1)	Control Inputs	/\loo	V <sub>CC</sub> =3.6V, One input at 3V, Other inputs at V <sub>CC</sub> or GND				300			2000	μΑ	
			V <sub>CC</sub> =2.3V	V <sub>I</sub> =0	I <sub>I</sub> =64mA		5	8			15	Ω
			TYP at	V <sub>1</sub> –0	I <sub>I</sub> =24mA		5	8			15	Ω
Resistor between	two	В	$V_{CC}=2.5V$	V₁=1.7V	I <sub>I</sub> =15mA		27	40			60	Ω
ports (Note 2)		R <sub>ON</sub>		\/ <b>-</b> 0\/	I <sub>I</sub> =64mA		5	7			11	Ω
			V <sub>CC</sub> =3V	V <sub>I</sub> =0V	I <sub>I</sub> =24mA		5	7			11	Ω
				V <sub>I</sub> =2.4V	I <sub>I</sub> =15mA		10	15			26	Ω

Notes: 1.This is the increase in supply current for each input that is at the specified voltage level, rather than  $V_{CC}$  or GND.

2. Measured by the voltage drop between the A and the B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

## **■ SWITCHING CHARACTERISTICS**

See Fig. 1 and Fig. 2 for test circuit and waveforms.

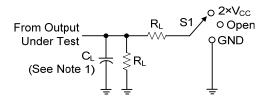
DADAMETED	SYMBOL	TEST CONDITIONS	T <sub>A</sub> =25°C			T <sub>A</sub> =-40°C~+125°C			UNIT
PARAMETER	STIMBOL	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
Propagation Delay From		V <sub>CC</sub> =2.5V±0.2V			0.15			0.3	ns
Input (A or B) (Note) to Output (B or A)	t <sub>pd</sub>	V <sub>CC</sub> =3.3V±0.3V			0.25			0.5	ns
Propagation Delay From	$(t_{PLH}/t_{PHL})$	V <sub>CC</sub> =2.5V±0.2V	1.8		7.3			8.8	ns
Input (S) to Output (A or B)		V <sub>CC</sub> =3.3V±0.3V	1.8		6.8			8.3	ns
Propagation Delay From		V <sub>CC</sub> =2.5V±0.2V	1.7		7			9	ns
Input (S) to Output (A or B)	$t_{en}$	V <sub>CC</sub> =3.3V±0.3V	1.7		6.5			8.5	ns
Propagation Delay From	(t <sub>PZL</sub> /t <sub>PZH</sub> )	V <sub>CC</sub> =2.5V±0.2V	1.9		7			9	ns
Input ( OE ) to Output (A or B)	(PZL/PZH)	V <sub>CC</sub> =3.3V±0.3V	2.0		6.5			8.5	ns
Propagation Delay From		V <sub>CC</sub> =2.5V±0.2V	1		5.5			7.5	ns
Input (S) to Output (A or B)	t <sub>dis</sub> (t <sub>PLZ</sub> /t <sub>PHZ</sub> )	V <sub>CC</sub> =3.3V±0.3V	1		5.3			7.3	ns
Propagation Delay From		V <sub>CC</sub> =2.5V±0.2V	1		5.5			7	ns
Input ( OE ) to Output (A or B)		V <sub>CC</sub> =3.3V±0.3V	1.6		5.5			7	ns

Note: The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance, when driven by an ideal voltage source (zero output impedance).

# ■ **OPERATING CHARACTERISTICS** (T<sub>A</sub>=25°C, unless otherwise specified)

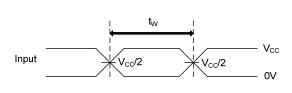
PARAMET	ER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Control input Capacitance	Control Inputs	Cı	V <sub>O</sub> =3V or 0		3		pF
I/O Capacitance	A Port	_	V =3V or 0 OF =V		10.5		рF
(OFF)	B Port	C <sub>IO(OFF)</sub>	$V_0$ =3V or 0, OE = $V_{CC}$		5.5		рF

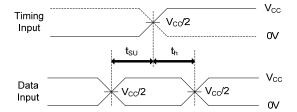
# **■ TEST CIRCUIT AND WAVEFORMS**



$V_{CC}$	C <sub>L</sub>	$R_L$	VΔ
2.5V±0.2V	30pF	500Ω	0.15V
3.3V±0.3V	50pF	500Ω	0.3V

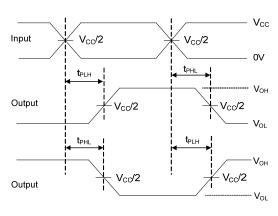
TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
$t_{PLZ}/t_{PZL}$	2×Vcc
$t_{PHZ}/t_{PZH}$	GND

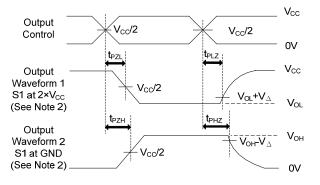




#### **PULSE DURATION**

SETUP AND HOLD TIMES





PROPAGATION DELAY TIMES

**ENABLE AND DISABLE TIMES** 

Notes: 1. C<sub>L</sub> includes probe and jig capacitance.

- 2. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
  - Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- 3. All input pulses are supplied by generators having the following characteristics:  $P_{RR} \le 10 MHz$ ,  $Z_O = 50 \Omega$ ,  $t_r \le 2 ns$ .
- 4.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- 5.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- 6.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

#### Load circuitry and voltage waveforms

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